

May 1999

# LM160/LM360 High Speed Differential Comparator

## **General Description**

The LM160/LM360 is a very high speed differential input, complementary TTL output voltage comparator with improved characteristics over the  $\mu A760/\mu A760C$ , for which it is a pin-for-pin replacement. The device has been optimized for greater speed, input impedance and fan-out, and lower input offset voltage. Typically delay varies only 3 ns for overdrive variations of 5 mV to 400 mV.

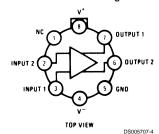
Complementary outputs having minimum skew are provided. Applications involve high speed analog to digital convertors and zero-crossing detectors in disk file systems.

## **Features**

- Guaranteed high speed: 20 ns max
- Tight delay matching on both outputs
- Complementary TTL outputs
- High input impedance
- Low speed variation with overdrive variation
- Fan-out of 4
- Low input offset voltage
- Series 74 TTL compatible

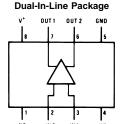
## **Connection Diagrams**

Metal Can Package



Order Number LM160H/883 (Note 1) or LM360H See NS Package Number H08C

Note 1: Also available in SMD# 5962-8767401



TOP VIEW DS005707-5

Order Number LM360M or LM360N See NS Package Number M08A or N08E Absolute Maximum Ratings (Notes 6, 8)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Operating Temperature Range

Storage Temperature Range  $-65^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$ 

Lead Temperature

(Soldering, 10 sec.) 260°C

Soldering Information
Dual-In-Line Package

Soldering (10 seconds)

Small Outline Package

Vapor Phase (60 seconds) 215°C Infrared (15 seconds) 220°C

260°C

See AN-450 "Surface Mounting Methods and Their Effect on Product Reliability" for other methods of soldering surface mount devices.

## **Electrical Characteristics**

 $(T_{MIN} \le T_A \le T_{MAX})$ 

Parameter	Conditions	Min	Тур	Max	Units
Operating Conditions					
Supply Voltage V <sub>CC</sub> <sup>+</sup>		4.5	5	6.5	V
Supply Voltage V <sub>CC</sub> <sup>-</sup>		-4.5	-5	-6.5	V
Input Offset Voltage	$R_S \le 200\Omega$		2	5	mV
Input Offset Current			0.5	3	μΑ
Input Bias Current			5	20	μΑ
Output Resistance (Either Output)	V <sub>OUT</sub> = V <sub>OH</sub>		100		Ω
Response Time	$T_A = 25^{\circ}C, V_S = \pm 5V \text{ (Notes 2, 7)}$		13	25	ns
	$T_A = 25^{\circ}C, V_S = \pm 5V \text{ (Notes 3, 7)}$		12	20	ns
	$T_A = 25^{\circ}C, V_S = \pm 5V \text{ (Notes 4, 7)}$		14		ns
Response Time Difference between Outputs					
$(t_{pd} \text{ of } +V_{IN1}) - (t_{pd} \text{ of } -V_{IN2})$	T <sub>A</sub> = 25°C (Notes 2, 7)		2		ns
$(t_{pd} \text{ of } +V_{IN2}) - (t_{pd} \text{ of } -V_{IN1})$	T <sub>A</sub> = 25°C (Notes 2, 7)		2		ns
$(t_{pd} \text{ of } +V_{IN1}) - (t_{pd} \text{ of } +V_{IN2})$	T <sub>A</sub> = 25°C (Notes 2, 7)		2		ns
$(t_{pd} \text{ of } -V_{IN1}) - (t_{pd} \text{ of } -V_{IN2})$	T <sub>A</sub> = 25°C (Notes 2, 7)		2		ns
Input Resistance	f = 1 MHz		17		kΩ
Input Capacitance	f = 1 MHz		3		pF
Average Temperature Coefficient of	$R_S = 50\Omega$		8		μV/°C
Input Offset Voltage					
Average Temperature Coefficient of			7		nA/°C
Input Offset Current					
Common Mode Input Voltage Range	V <sub>S</sub> = ±6.5V	±4	±4.5		V
Differential Input Voltage Range		±5			V
Output High Voltage (Either Output)	$I_{OUT} = -320 \mu A, V_{S} = \pm 4.5 V$	2.4	3		V
Output Low Voltage (Either Output)	I <sub>SINK</sub> = 6.4 mA		0.25	0.4	V
Positive Supply Current	V <sub>S</sub> = ±6.5V		18	32	mA
Negative Supply Current	V <sub>S</sub> = ±6.5V		-9	-16	mA

Note 2: Response time measured from the 50% point of a 30 mVp-p 10 MHz sinusoidal input to the 50% point of the output.

Note 3: Response time measured from the 50% point of a 2 Vp-p 10 MHz sinusoidal input to the 50% point of the output.

Note 4: Response time measured from the start of a 100 mV input step with 5 mV overdrive to the time when the output crosses the logic threshold.

Note 5: Typical thermal impedances are as follows:

Cavity DIP (J):  $\theta_{jA}$  135°C/W Header (H)  $\theta_{jA}$  165°C/W (Still Air) Molded DIP (N):  $\theta_{jA}$  130°C/W  $\theta_{jA}$  130°C/W  $\theta_{jA}$  130°C/W  $\theta_{jA}$  150°C/W (400 LF/min Air Flow)

Note 6: The device may be damaged if used beyond the maximum ratings.

Note 7: Measurements are made in AC Test Circuit, Fanout = 1

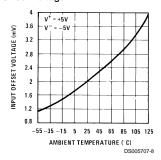
Note 8: Refer to RETS 160X for LM160H, LM160J-14 and LM160J military specifications.

## **Electrical Characteristics** (Continued)

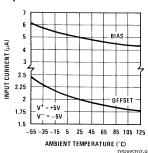
Note 9: Human body model, 1.5 k $\Omega$  in series with 100 pF.

# **Typical Performance Characteristics**

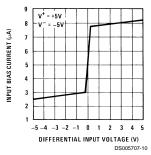
### Offset Voltage



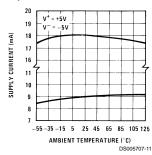
### Input Current vs Ambient Temperature



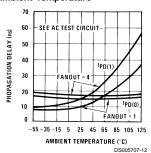
## Input Characteristics



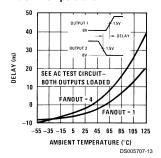
#### Supply Current vs Ambient Temperature



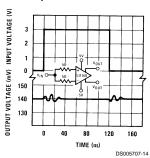
### Propagation Delay vs Ambient Temperature



#### Delay of Output 1 With Respect to Output 2 vs Ambient Temperature

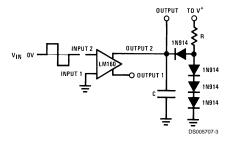


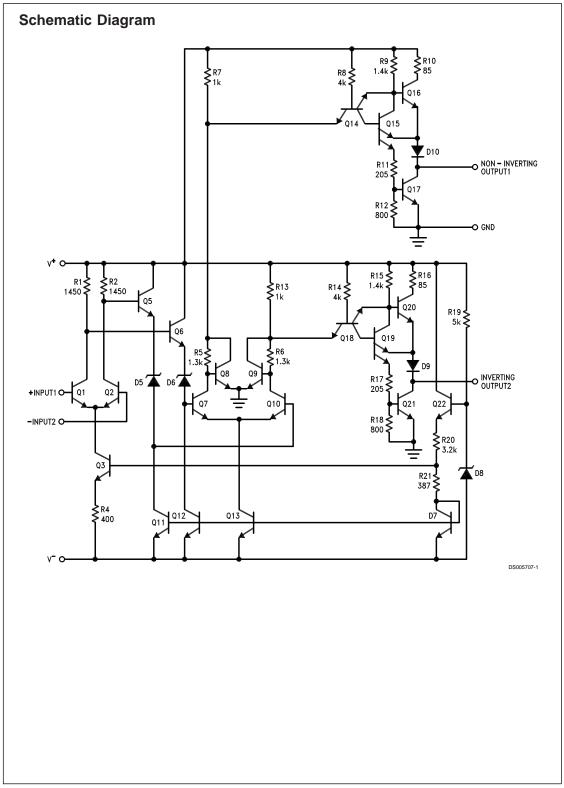
#### Common-Mode Pulse Response



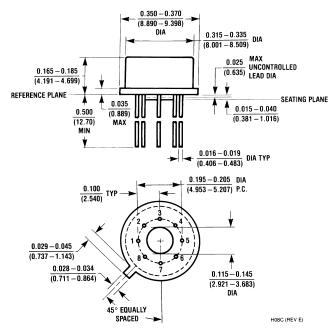
3 www.national.com

# **AC Test Circuit**

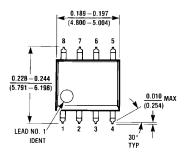


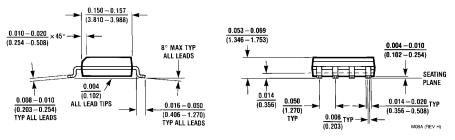






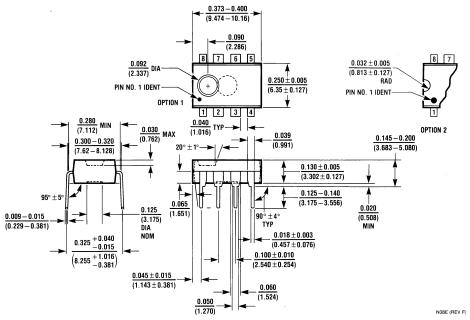
Metal Can Package (H)
Order Number LM160H/883 or LM360H
NS Package Number H08C





Molded Dual-In-Line Package (M) Order Number LM360M NS Package Number M08A

## Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



Molded Dual-In-Line Package (N) Order Number LM360N NS Package Number N08E

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